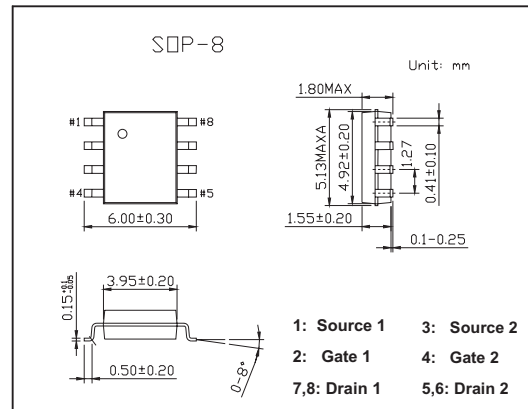
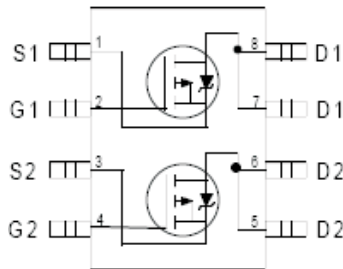


# KRF7104

### ■ Features

- Advanced Process Technology
- Ultra Low On-Resistance
- Dual P-Channel MOSFET
- Surface Mount
- Available in Tape & Reel
- Dynamic dv/dt Rating
- Fast Switching



### ■ Absolute Maximum Ratings $T_a = 25^\circ\text{C}$

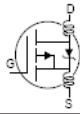

Parameter	Symbol	Rating	Unit
Continuous Drain Current, $V_{GS} @ 10V @ T_a = 25^\circ\text{C}$	$I_D$	-2.3	A
Continuous Drain Current, $V_{GS} @ 10V @ T_a = 70^\circ\text{C}$	$I_D$	-1.8	
Pulsed Drain Current *1	$I_{DM}$	-10	
Power Dissipation @ $T_C = 25^\circ\text{C}$	$P_D$	2.0	W
Linear Derating Factor		0.016	W/ $^\circ\text{C}$
Gate-to-Source Voltage	$V_{GS}$	$\pm 12$	V
Peak Diode Recovery $dv/dt$ *3	$dv/dt$	-3	V/nS
Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to + 150	$^\circ\text{C}$
Maximum Junction-to-Ambient *2	$R_{\theta JA}$	62.5	$^\circ\text{C}/\text{W}$

\*1 Repetitive rating; pulse width limited by max. junction temperature.

\*2 Surface mounted on FR-4 board,  $t \leq 10\text{sec}$ .

\*3  $I_{SD} \leq -2.3\text{A}$ ,  $di/dt \leq 100\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J \leq 150^\circ\text{C}$

■ Electrical Characteristics Ta = 25°C

Parameter	Symbol	Testconditons	Min	Typ	Max	Unit
Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = -250 \mu A$	-20			V
Breakdown Voltage Temp. Coefficient	$\Delta V_{(BR)DSS} / \Delta T_J$	$I_D = -1mA, \text{Reference to } 25^\circ C$		-0.015		V/°C
Static Drain-to-Source On-Resistance	$R_{DS(on)}$	$V_{GS} = -10V, I_D = -1.0A^{*1}$		0.19	0.25	$\Omega$
		$V_{GS} = -4.5V, I_D = -0.50A^{*1}$		0.30	0.40	
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250 \mu A$	-1.0		-3.0	V
Forward Transconductance	$g_{fs}$	$V_{DS} = -15V, I_D = -2.3A^{*1}$		2.5		S
Drain-to-Source Leakage Current	$I_{DSS}$	$V_{DS} = -16V, V_{GS} = 0V$			-2.0	$\mu A$
		$V_{DS} = -16V, V_{GS} = 0V, T_J = 55^\circ C$			-25	
Gate-to-Source Forward Leakage	$I_{GSS}$	$V_{GS} = -12V$			-100	nA
Gate-to-Source Reverse Leakage		$V_{GS} = 12V$			100	
Total Gate Charge	$Q_g$	$I_D = -2.3A$		9.3	25	nC
Gate-to-Source Charge	$Q_{gs}$	$V_{DS} = -10V$		1.6		
Gate-to-Drain ("Miller") Charge	$Q_{gd}$	$V_{GS} = -10V^*$		3.0		
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = -10V$		12	40	ns
Rise Time	$t_r$	$I_D = -1.0A$		16	40	
Turn-Off Delay Time	$t_{d(off)}$	$R_G = 6 \Omega$		42	90	
Fall Time	$t_f$	$R_D = 10 \Omega^*$		30	50	
Internal Source Inductance	$L_s$	Between lead, 6mm(0.25in.) from package and center of die contact 		4.0		nH
Internal Drain Inductance	$L_D$				6.0	
Input Capacitance	$C_{iss}$	$V_{GS} = 0V$		290		pF
Output Capacitance	$C_{oss}$	$V_{DS} = -15V$		210		
Reverse Transfer Capacitance	$C_{rss}$	$f = 1.0MHz$		67		
Continuous Source Current (Body Diode)	$I_S$	MOSFET symbol showing the integral reverse p-n junction diode. 			-2.0	A
Pulsed Source Current (Body Diode) *2	$I_{SM}$					
Diode Forward Voltage	$V_{SD}$	$T_J = 25^\circ C, I_S = -1.5A, V_{GS} = 0V^{*1}$			-1.2	V
Reverse Recovery Time	$t_{rr}$	$T_J = 25^\circ C, I_F = -1.5A$		69	100	ns
Reverse Recovery Charge	$Q_{rr}$	$di/dt = -100A/\mu s^{*1}$		90	140	$\mu C$

\*1 Pulse width  $\leq 300 \mu s$ ; duty cycle  $\leq 2\%$ .

\*2 Repetitive rating; pulse width limited by max. junction temperature.